Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/608,029	DESPRES ET AL.
Examiner	Art Unit
M. Franco Salvoza	1648

SEARCHED				
Class	Subclass	Date	Examiner	
530	300	9/15/2006	MFS	
424	218.1	9/15/2006	MFS	
	204.1	9/15/2006	MFS	
530	350	9/15/2006	MFS	
435	6	9/15/2006	MFS	
	5	9/15/2006	MFS	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
see	above			
	1			

SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
STIC tech search; STIC size limited oligomer search; See results attached and sequence search results in SCORE	9/15/2006	MFS
EAST (US-PGPUB; USPAT; EPO; JPO; DERWENT) (updated) (see attached results)	9/15/2006	MFS
PUBMED (updated)(see attached results)	9/15/2006	MFS